

<b>Notice of References Cited</b>		Application/Control No. 10/617,530	Applicant(s)/Patent Under Reexamination CHEN ET AL.	
		Examiner Samuel G. Neway	Art Unit 2626	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,999,916	02-2006	Lin et al.	704/8
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
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**NON-PATENT DOCUMENTS**

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	U	"CEL (Chinese-English Lookup)", <a href="http://web.archive.org/web/20010309104519/http://home.iprimus.com.au/richwarm/cel/cel.htm">http://web.archive.org/web/20010309104519/http://home.iprimus.com.au/richwarm/cel/cel.htm</a> , March 2001.
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